

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

	0024 SHVCI CIC	ck vancy Road, San	Jose, CA - 73136		
	PRODUCT	PROCESS (	CHANGE NO	OTICE (PCN)	)
PCN #: A1903-0 Product Affected:	Date: M 4RCD0124KC0ATG 4RCD0124KC0ATG8 4RCD0124KC0ATG8/B 4RCD0124KC0ATG8/M 4RCD0124KC0ATGI 4RCD0124KC0ATGI	March 28, 2019	MEANS OF DISTIN  □ Product Mark  ■ Back Mark  □ Date Code  □ Date Code  □ Other	NGUISHING CHANGE Lot # will have a '	
Date Effective: Ju	une 28, 2019				
Contact: II	DT PCN DESK		Attachment:	Yes	□ No
E-mail:	cndesk@idt.com		Samples:	Please contact your los sample request & avai	cal sales representative for lability.
DESCRIPTION AND DIE Technology  □ Wafer Fabrication □ Assembly Procest □ Equipment ■ Material □ Testing ■ Manufacturing S □ Data Sheet □ Other	SS	This notification is bump location on transferred from A discontinuing the Amkor Korea is c	the above products. It is a maker Philippines to assembly processes of the urrently a qualified II to the moisture performance to the moisture performance in the products.	n addition, the assembly Amkor Korea as a result of these products.	t of Amkor Philippines
-	UALIFICATION SUMMARY een successfully completed. The		SL rating.		
IDT records indica to grant approval o it will be assumed IDT reserves the ri	that this change is acceptable. ght to ship either version manufactor has been depleted.	cation of this change. If IDT does not receive	ve acknowledgement	t within 30 days of this	
Customer:		☐ Appro	oval for shipment	ts prior to effective	date.
Name/Date:		E-Mail Addre	ss:		
Title:		Phone# /Fax#	:		
CUSTOMER COM					
	EDGMENT OF RECEIPT:	D.F	TE		

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## PRODUCT/PROCESS CHANGE NOTICE (PCN)

#### **ATTACHMENT 1 - PCN # : A1903-01**

PCN Type: Add alternate Bump Location & Change Assembly Location & Assembly Material Sets

**Data Sheet Change:** N/A

## **Detail Of Change:**

This notification is to advise our customers that IDT is adding Amkor Korea as an alternate bump location on the above products. In addition, the assembly location will also be transferred from Amkor Philippines to Amkor Korea as a result of Amkor Philippines discontinuing the assembly processes of these products.

Amkor Korea is currently a qualified IDT Subcontractor.

There is no change in form, fit and function of the products including RoHS compliance and MSL rating.

IDT requests customers to respond to this notice within 30 days, with an indication if samples will be required. Samples must be placed within 30 days if required for qualification and approval to avoid any disruption in supply.

#### FCCSP-48: Qualified Material Sets, by Assembly Subcontractor

	Existing	New		
Die Bump Location	ATT - Amkor, Taiwan	ATT - Amkor, Taiwan ATK - Amkor, Korea		
Material Set / Assembly	ATP - Amkor, Philippines	ATK - Amkor, Korea		
Die Bump	Sn1.8Ag	Sn1.8Ag		
Underfill Material	MUF-1	MUF-32		
Substrate	AUS703-140PS 4L	AUS703-140PS 4L		
Solder Balls	Sn96.5/Ag3.0/Cu0.5	Sn96.5/Ag3.0/Cu0.5		



# PRODUCT/PROCESS CHANGE NOTICE (PCN)

### **ATTACHMENT 1 - PCN # : A1903-01**

## **Qualification Information and Qualification Data:**

**Affected Packages:** FCCSP-253

**Assembly Material:** The affected package type is using the respective subcon standard materials as

shown on page 1 of this attachment. Qualification testing was completed on the

worse case package.

Qual Plan & Results: Tests are in accordance with JEDEC47 recommended tests

**Qualification Vehicle: FCCSP-253** (3 lots)

		Test Results (Rej/SS)			
Test Description	Test Method	Lot 1	Lot 2	Lot 3	
<sup>1</sup> HAST - biased (130 °C/85% RH, 96 Hrs)	JESD22-A110	0 / 25	0 / 25	0 / 25	
<sup>1</sup> HAST - unbiased (130 °C/85% RH, 96 Hrs)	JESD22-A118	0 / 25	0 / 25	0 / 25	
<sup>1</sup> Temperature Cycling (-55°C to 125°C, 700 cycles)	JESD22-A104	0 / 25	0 / 25	0 / 25	
High Temperature Storage Test (150°C, 1000 hours)	JESD22-A103	0 / 25	0 / 25	0 / 25	
Moisture Sensitivity Level, MSL	J-STD-020C	0 / 25	0 / 25	-	

Notes: 1. HAST and Temperature Cycle were subjected to Preconditioning per JESD22-A113 for MSL 3.